

Search Notes

Application/Control No.

10/813,807

Examiner

Anand Bhatnagar

Applicant(s)/Patent under
Reexamination

KUDUVALLI, GOPINATH

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	100,128, 280	8/19/2007	AB
128	922	8/19/2007	AB
378	4	8/19/2007	AB
708	403	8/19/2007	AB
702	77	8/19/2007	AB
tex	see sheet	8/19/2007	AB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Interference printout		8/19/2007	AB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/100,128-132;128/922;378/4- 27;708/403,404,405,821;702/77;359/2 9,559;370/210.ccls: W/ text	8/19/2007	AB
Inventor	8/19/2007	AB
IEEE	8/19/2007	AB
((3D volume (three near4 dimension\$2) tomogra\$6) and frequen\$4 and (sampl\$4 same surface\$1) and (FFT DFT Fourier) and (IFT...	8/19/2007	AB